



CHENMKO ENTERPRISE CO.,LTD

Halogens free devices

**SMALL FLAT
PNP Epitaxial Transistor**

VOLTAGE 25 Volts CURRENT 5 Ampere

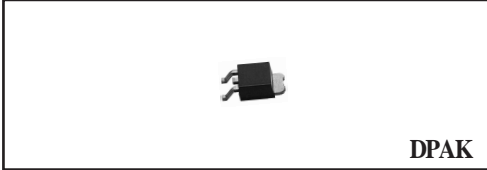
CHT210PGP

FEATURE

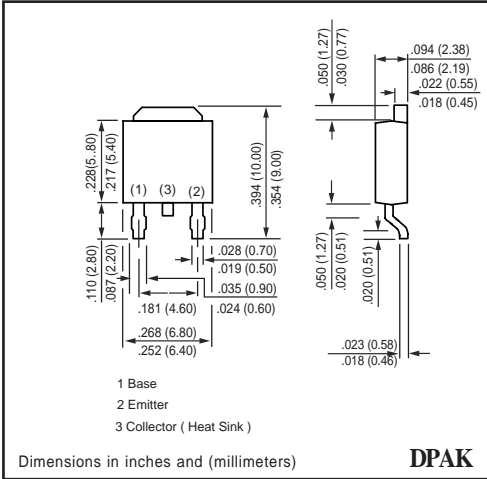
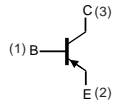
- * Small flat package. (DPAK)
- * Low saturation voltage $V_{CE(sat)} = -0.3V(\text{max.})(I_C = -500mA)$
- * High saturation current capability.

CONSTRUCTION

- * PNP Switching Transistor



CIRCUIT



MAXIMUM RATINGS (At $T_A = 25^\circ C$ unless otherwise noted)

RATINGS	CONDITION	SYMBOL	MIN.	MAX.	UNITS
Collector - Base Voltage	Open Emitter	V_{CB0}	-	-40	Volts
Collector - Emitter Voltage	Open Base	V_{CE0}	-	-25	Volts
Emitter - Base Voltage	Open Collector	V_{EB0}	-	-8	Volts
Collector Current DC		I_C	-	-5	Amps
Peak Collector Current		I_{CM}	-	-10	Amps
Peak Base Current		I_{BM}	-	-1.0	Amps
Total Power Dissipation	$T_A \leq 25^\circ C$	P_{TOT}	-	1400	mW
Storage Temperature		T_{STG}	-55	+150	$^\circ C$
Junction Temperature		T_J	-	+150	$^\circ C$

RATING CHARACTERISTIC CURVES (CHT210PGP)

CHARACTERISTICS (At $T_A = 25^\circ\text{C}$ unless otherwise noted)

PARAMETERS	CONDITION	SYMBOL	MIN.	TYPE	MAX.	UNITS
Collector Cut-off Current	$I_E=0; V_{CB}=-40\text{V}$	I_{CBO}	-	-	-0.1	μA
Emitter Cut-off Current	$I_C=0; V_{EB}=-8\text{V}$	I_{EBO}	-	-	-0.1	μA
DC Current Gain	$V_{CE}=-1\text{V}$; Note 1 $I_C=-500\text{mA}$ $I_C=-2.0\text{A}$ $I_C=-5.0\text{A}; V_{CE}=-2\text{V}$	h_{FE}	70 45 10	- - -	- 180 -	
Collector-Emitter Saturation Voltage	$I_C=-500\text{mA}; I_B=-50\text{mA}$ $I_C=-2\text{A}; I_B=-200\text{mA}$ $I_C=-5\text{A}; I_B=-1\text{A}$	V_{CEsat}	- - -	- - -	-0.3 -0.75 -1.8	Volts
Base-Emitter Saturation Voltage	$I_C=-5\text{A}; I_B=-1\text{A}$	V_{BEsat}	-	-	-2.5	Volts
Collector Capacitance	$I_E=I_C=0; V_{CB}=-10\text{V};$ $f=0.1\text{MHz}$	C_C	-	-	120	pF
Transition Frequency	$I_C=-0.1\text{A}; V_{CE}=-10\text{V};$ $f=100\text{MHz}$	f_T	65	-	-	MHz

Note :

1. Pulse test: $t_p \leq 300\mu\text{Sec}$; $\delta \leq 0.02$.